## Application/Control No. Applicant(s)/Patent Under Reexamination 10/029,093 SADAKA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2814 Long Pham **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,594,297 B1 07-2003 Hayakawa, Toshiro 372/46 Α В US-2002/0009894 01-2002 Chino, Toyoji 438/712 С US-D US-E US-F US-US-G Н USı US-J US-Κ US-US-L US-FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 2001-229584 01-2003 Japan 0 2001-317714 05-2003 Japan Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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